
Review

Transparent p-Type Semiconductors: Copper-Based Oxides and Oxychalcogenides

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Abstract: While p-type transparent conducting materials (TCMs) are crucial for many optoelectronic applications, their performance is still not satisfactory. This has impeded the development of many devices such as photovoltaics, sensors, and transparent electronics. Among the various p-type TCMs proposed so far, Cu-based oxides and oxychalcogenides have demonstrated promising results in terms of their optical and electrical properties. Hence, they are the focus of this current review. Their basic material properties, including their crystal structures, conduction mechanisms, and electronic structures will be covered, as well as their device applications. Also, the development of performance enhancement strategies including doping/co-doping, annealing, and other innovative ways to improve conductivity will be discussed in detail.

Keywords: p-type semiconductors; transparent oxides; delafossite; oxychalcogenide

1. Introduction

Transparent conducting oxides (TCOs) possess high electrical conductivity and good optical transparency in the visible light range, and they have been intensively studied over the past few decades due to their important roles in electronic industries including photovoltaic cells (PV cells), touch screen displays, solid-state sensors, organic light-emitting diodes (OLEDs), and liquid crystal displays [1–3]. Currently, in the electronics industry, many different materials, especially impurity-doped materials, are used as TCOs for the applications. Three major materials are In2O3 doped with Sn (ITO), ZnO doped with Al (AZO), Fluor tin oxide or SnO2–F (FTO), and SnO2 doped with Sb (ATO) [4,5]. Among them, ITO, with its great electrical conductivity around 1000 S·cm−1 and optical transparency greater than 80%, has a market share higher than 97% [6,7].

However, the aforementioned materials all belong to n-type TCOs, which show n-type conductivity. The popularity of n-type TCOs arises from their preferable electronic properties [8]. For n-type TCOs, the electrons as charge carriers move in the conduction band minimum (CBM). The CBM is largely formed by the spatially spread metal-s orbitals, resulting in a well-dispersed CBM and high electron mobility. In addition, the low formation energy of native intrinsic defects induces a high electron concentration and stable n-type electrical conductivity after impurity doping [9]. On the contrary, the development of high-performance p-type TCOs is very challenging [10,11], and it remains a grand challenge for researchers to solve. Indeed, it is very difficult to find p-type TCO with high conductivity due to the inherent low mobility of holes in the oxides. As can be seen in Figure 1,
the effective mass of a hole is relatively higher than that of an electron [12]. This is caused by the valence band maximum (VBM) for hole transport being mainly formed by highly localized oxygen 2p orbitals, leading to low hole mobility. Moreover, the low formation energy of intrinsic donor defect and relatively high acceptor formation energy limit the number of hole carriers [11].

![Figure 1. Effective mass distribution of both electrons and holes in selected binary and ternary oxides. Reproduced with permission from Ref. [12]. Copyright 2013 Springer Nature.](image1)

On the other hand, p-type TCOs are extremely important in many applications. For example, a p-type TCO, with its larger work function than its n-type counterpart, is more suitable for OLED devices [13,14]. However, with performance sacrifice, many of the current OLED applications use ITO as the transparent electrode instead of a p-type anode material due to the lack of high-performance p-type TCO [13,14]. In the perovskite solar cells, a hole transport layer (HTL) usually is made of the popular semi-metallic organic material poly(3,4-ethylenedioxythiophene):poly(styrenesulfonate) (PEDOT:PSS), and this has been shown to negatively affect the stability of the device, which is a serious issue for perovskite solar cells [15–18]. Moreover, in the field of transparent electronics, wide gap oxides are no longer passive components in the device. Instead, transparent oxides play an essential role as active layers, similar to Si in current semiconductor industry. After achieving high-performance p-type TCOs, transparent p–n junctions and a complementary metal oxide semiconductor (CMOS) could be fabricated for various applications with many more advantages than its unipolar transistors such as lower heat generation, higher circuit density, and lower energy consumption [19–21]. It is also believed that transparent electronics will become one of the most promising technologies for next-generation flat panel display [22], and the forecast shows that the transparent display would help create a $87.2 billion market by 2025, as can be seen in Figure 2 [2].

![Figure 2. Transparent display market. Reproduced with permission from Ref. [2]. Copyright 2012 Wiley.](image2)
In order for p-type TCOs to achieve reasonable electrical properties, in 1997, Kawazoe et al. introduced a concept called “Chemical Modulation of the Valence Band” (CMVB), as a way to deal with the aforementioned problem [23,24]. The delafossite structured CuAlO₂ was prepared and discussed in that work. In delafossites, Cu⁺ has a closed shell of 3d¹⁰ orbitals which would hybridize with O 2p orbitals and modify the VBM and make the hole more delocalized so that it increases the hole mobility [25]. This hybridization is possible because the energy level of Cu 3d¹⁰ is close to that of O 2p. Subsequently, several other types of delafossites with the structure CuMO₂ (M = Al [26–28], Cr [29–31], Ga [32–34], In [35–37], Sc [38–40], Y [41–43], Fe [44–46], and B [47–49]) and delafossite-related oxide SrCu₂O₂ [50–52] have been investigated. In 2001, the delafossite with a rather high p-type conductivity of 220 S·cm⁻¹ was achieved by Mg-doped CuCrO₂, but the transparency is not satisfying [30]. Many of these delafossites have been used in the applications such as OLEDs as a hole injection layer (HIL) or hole transport layer (HTL) due to their suitable work function, good stability, and preferable electronic properties [53,54]. While a lot of attention has been paid to such p-type TCOs, it seems very challenging for delafossites to attain the high conductivity and high transparency that would make them comparable to current n-type TCOs [55]. The rather low conductivity is caused by their deep acceptor level [56], and polaronic nature [43,57]. In some cases, the transparency of a delafossite is limited by the interband transitions [58]. The band-engineering CMVB technique was later used on other Cu⁺-based materials, especially materials with chalcogens such CuₓS, Cu₂Se, and Cu₂Te [59]. Even though chalcogen-based TCOs have greater hole mobility due to their stronger hybridization with Cu 3d states by the chalcogens than oxygen [10], they suffer greatly from their narrow band gap, which limits their visible light transparency [60]. Therefore, it appears that a high-performance TCO should include oxygen for a large band gap and chalcogen for a high hole mobility. Subsequently, layered oxychalcogenides have been developed to demonstrate a large band gap and high hole mobility due to the hybridization of Cu and chalcogens. Layered oxychalcogenide has alternate layers of [LnO]+ (Ln = La, Y, Pr, etc.) and [CuCh]- (Ch = S, Se, Te, etc.), in which the [CuCh]- is essential for its p-type conductivity and band gap [61,62]. It has been reported that the conduction band minimum (CBM) and the valence band maximum (VBM) comprise a Cu–Ch hybridized band and Cu–Ch anti-bonding band, respectively [13,63]. This forms a direct band gap that allows a direct transition of charge carriers, which is more useful in applications than indirect band-gap materials [10,62,63]. While oxychalcogenides have promising properties that enable them to be used as future transparent p-type materials, their hole mobility is around 10⁰ cm²·V⁻¹·s⁻¹ or less. For applications such as thin-film transistors (TFTs), which require materials with high mobility, cuprous oxide (Cu₂O), with its high hole mobility greater than 2.0 × 10² cm²·V⁻¹·s⁻¹, seems more suitable [64], even though it has a small band gap (2.0–2.5 eV) that is only transparent for part of the visible light range [65–67]. The high mobility of Cu₂O originates from the rather delocalized VBM, which is formed mainly by Cu d states, and the VB is formed by the hybridization of O 2p and Cu 3d orbitals [68,69]. In this review, we will focus on the discussion of three types of materials, including delafossites, oxychalcogenides, and copper oxides.

2. Preparation and Properties of Materials

2.1. Delafossite (CuMO₂)

Before the realization of CuAlO₂ delafossite (band gap > 3 eV) as a transparent p-type oxide [24], p-type conductivity in oxides with large band gaps was too low to be used in any industrial applications. As briefly mentioned above in the introduction, the low electrical conductivity is the result of the general electronic structure in the metal oxides. This is because oxygen 2p orbitals are generally at a much lower energy level than that of the metallic atoms in ionic metal oxides, leading to a highly localized and deep valence band that is formed by oxygen 2p orbitals. Holes generated in the oxides would be attracted and localized by oxygen ions, leading to very low hole mobility [8,23]. To tackle the problem of low hole mobility, the highly localized VB or VBM need to be modified to be more dispersed. To achieve such band modification, a design strategy named “Chemical Modulation of
the Valence Band” (CMVB) was proposed in 1997 [23, 24]. The cation selected by this strategy should possess the electronic configuration such that its highest shell electrons should be situated at similar energy levels as that of oxygen 2p orbitals. As shown in Figure 3a, this would introduce chemical bonds and make the newly formed VB or VBM more spatially dispersed. In addition, the selected cation should also have a closed shell valence state to prevent coloration in the transparent oxides caused by d–d transitions. After carefully selecting the right cations, it was found that both Cu$^+$ and Ag$^+$ possess suitable electronic configuration of $d^{10}$, and they are at a similar energy level as that of oxygen 2p orbitals [23]. When Cu$^+$ or Ag$^+$ cations are brought to oxygen ions, chemical bonds with a certain degree of covalency would be formed, and the VBM would be formed by the anti-bonding levels of the resulting band formation (as can be observed in Figure 3a). Besides the overlap of the orbitals to create dispersed VBs or VBM, the crystal structure is also important for the transparent oxide performance for two reasons. Firstly, the tetrahedral coordination of oxygen would ensure all eight of its electrons were involved in the four sigma bonds, as can be seen in Figure 3b [70]. As the non-bonded electrons that are normally present in oxides would result in the generated holes having low mobility, the absence of non-bonded electrons of oxygen would lead to a higher hole mobility. Secondly, the crystal structure of the delafossite is also advantageous to its optical properties. For the prototypical delafossite CuAlO$_2$, it has a layered structure with two alternating arrays comprising of Cu and the edge-sharing distorted MO$_6$ octahedral unit along the vertical axis, and the two layers are connected by the O–Cu–O bonds [43]. This reduces the cross-linking between Cu$^+$ as compared to that in Cu$_2$O, which would decrease the interaction between the $d^{10}$ electrons of Cu$^+$ ions. Since it has been reported that such $d^{10}$ electrons interaction between neighboring atoms would decrease the band gap such as the case in Cu$_2$O where interaction among three-dimensional 3$d^{10}$ electrons is present, the layered delafossite would improve the optical transparency [11, 24]. Therefore, the delafossite based on Cu$^+$ has been predicted to be a potential high performance candidate for p-type TCOs in terms of its electrical and optical properties. In addition, the doping of divalent atoms at the site of trivalent metal M is believed to greatly enhance the p-type conductivity of delafossites [11], even though the effect of size of the trivalent metal atom on the conductivity trend still remains under intense debate [30, 71]. It should be noted that even though both Cu$^+$ and Ag$^+$ have a suitable electronic configuration of $d^{10}$, Cu$^+$-based delafossites are usually preferred due to the following two reasons [49]. Firstly, Ag$^+$-based delafossites are difficult to be synthesized partially due to the low free energy of forming Ag$_2$O, and decomposition will occur at 300 $^\circ$C into O and Ag [72]. Secondly, it was shown experimentally that Ag$^+$-based delafossites exhibit lower conductivity compared to Cu$^+$-based delafossites due to unfavorable mixing between the Ag 4d and O 2p states [71, 73–75].

Delafossites with the formula CuMO$_2$ have two polytypes, namely a rhombohedral 3R and hexagonal 2H type, depending on the stacking sequence of the Cu and double layer MO$_2$. For the rhombohedral 3R type, the alternative Cu layer has the same orientation between each MO$_2$ layer within three layers, and each unit cell has three layers with the space group R$ar{3}$m (No. 166) (Figure 3b). For the hexagonal 2H type, each unit cell contains two layers with MO$_2$ and Cu layers with 180$^\circ$ offset for each alternating Cu layer with the space group P6$_3$/mmc (No. 194) (Figure 3c). It has been reported that certain delafossites such as CuAlO$_2$, CuGaO$_2$, and CuInO$_2$ generally prefer the rhombohedral 3R type, while other delafossites such as CuScO$_2$, CuYO$_2$, and CuLaO$_2$ normally adopt a hexagonal 2H form [76]. In addition, the former type of delafossite has an indirect band gap, and the many latter ones possess a direct band gap [43, 77, 78]. It should be noted that the relative energy difference between the two polytypes is generally rather small [79, 80], so the relative phase stability for each delafossite is still under debate [81]. Different synthesis routes and preparation conditions might result in different symmetries, and it is not uncommon to find the prepared delafossite with a mixture of both 3R and 2H polymorphs [82–84]. So far, most of the delafossites that have been used for p-type TCO applications are reported to possess rhombohedral 3R structures [49, 81, 85–87].
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As mentioned above, CuAlO$_2$ is the first material in the delafossite family to be prepared as a p-type transparent oxide back in 1997 [24], even though CuAlO$_2$ was already illustrated to possess p-type conductivity in 1984 [88]. Since its first introduction as a promising p-type TCO, a lot of research effort has been put on the development of delafossites with good electrical and optical properties. Since 1997, many thin film fabrication methods have been used to prepare transparent p-type CuMO$_2$ films, including vacuum-based routes such as radio-frequency magnetron sputtering (RFMS) [89,90], pulsed laser deposition (PLD) [32,91], chemical vapor deposition (CVD) [26,29], atomic layer deposition (ALD) [92,93] and non-vacuum based routes such as the hydrothermal/solvothermal method [94,95], sol-gel process [27,96], the spin-coating method [97,98], and the spray-coating method [99,100]. Each thin film fabrication method has its own advantages. For example, RFMS is relatively cost-efficient among all the vacuum-based methods, and is compatible with industrial applications for large scalability [101,102]; PLD is better at conserving the stoichiometry ratio in the target and producing high-quality epitaxy thin films [103–105]; and ALD has good control of both elemental composition and thin film morphology [106,107]. While many high-performance delafossites have been prepared via these state-of-art vacuum-based approaches, the chemical solution-based method has attracted more and more research attention recently, as it allows for low-cost fabrication, roll-to-roll capability, low-temperature synthesis, high throughput, and the possibility for special nanostructures [108–110]. Today, the above-mentioned thin film approaches are used in various research groups to prepare CuMO$_2$, as discussed briefly below. The electrical and optical properties of the selected high-performance delafossites are tabulated in Table 1.

CuAlO$_2$ was firstly prepared as a transparent p-type oxide in 1997 by using PLD at a substrate temperature of 700 °C [24]. The deposited thin film of 500 nm belongs to the rhombohedral 3R type, and it has a p-type conductivity of around 1 S·cm$^{-1}$ and an optical band gap of 3.5 eV with a poor transmittance around 30% [24]. After this, the same group investigated the electronic properties of CuAlO$_2$, in more detail, and they obtained thin film with conductivity around 0.3 S·cm$^{-1}$ and transparency of 70% via the PLD approach [111]. It should be noted that the delafossite CuMO$_2$ phase is not trivial to achieve due to the unstable oxidation state of Cu$^+$ and the complex phase diagram of Cu, M, and O [112]. Later studies has been carried out to achieve phase-pure CuAlO$_2$, in order to eliminate common impurities such as Cu$_2$O$_4$ and CuO [91]. In 2000, Gong et al. developed a Cu–Al–O-based semiconductor thin film via the CVD method that is industrial compatible, and the p-type conductivity is as high as 2 S·cm$^{-1}$ [26]. As an attempt to further improve the electrical conductivity of intrinsic CuAlO$_2$, high-quality nanocrystalline oxide particles were prepared via the hydrothermal method, and the deposited thin film possesses a conductivity of 2.4 S·cm$^{-1}$ with a transparency at the 550-nm wavelength around 55% [94]. Similar to other semiconducting oxides, doping is usually an effective

![Figure 3.](image-url)
way to increase electrical conductivity. Various theoretical studies has been carried out on delafossite CuAlO$_2$ to study its doping possibility, and Group II (alkaline earth) elements were suggested as suitable dopants [113,114]. Detailed experimental evidence was shown by Dong et al., where 2% Mg improves the CuAlO$_2$ by three orders, although the final conductivity is only 0.083 S·cm$^{-1}$ [115]. Besides the hard work to improve the optoelectronic properties, the conducting mechanism and material physics were examined by both experiments and theoretical studies [87,116]. It has been shown that the close-packed Cu$^+$ alternative layers act as the hole transport path [117]. Due to its anisotropic structural properties, the ab-planes have a hole mobility that is 25 times lower than the c-axis, where the mobility along the c-axis is around 3.0 cm$^2$·V$^{-1}$·s$^{-1}$ [118]. The p-type conductivity of CuAlO$_2$ was proven to be originated from the Cu vacancies and Cu on Al antisites in the oxides, which have a rather small formation energy, and Cu vacancy is a shallow-level defect with an ionization energy of 0.7 eV [87,89,118]. In contrast, O interstitials were found to be not responsible for the p-type conductivity, as they are deep-level defects and relatively unstable [87,119]. In addition, it was generally believed that the conduction mechanism for CuAlO$_2$ and other delafossites is via an activated small polaronic hopping mechanism, in which distorted lattice and trapped holes interact and move between Cu sites, leading to relatively low hole mobility [43,57,87,116]. In order to achieve a higher hole mobility of p-type conductivity, Yao et al. recently used an innovative way to enhance the hole mobility of CuAlO$_2$ with an ultra-high Hall mobility of 39.5 cm$^2$·V$^{-1}$·s$^{-1}$ [120]. Polycrystalline CuAlO$_2$ deposited on the Si substrate via RFMS was incorporated with different amount of non-isovalent CuO. The atomic ratio of Cu$^{2+}$/Cu$^+$ is varied, from 4.2% and 9.3%, to 22.8%, and the optical band gaps were changed from 3.79 eV and 3.72 eV to 3.46 eV , respectively. The high mobility achieved is found to be caused by the hybridization of Cu–O dimers in the CuAlO$_2$ lattice. The Cu–O dimers have a VBM of 0.6 eV , which is higher than that of CuAlO$_2$, so it would raise the VBM of the alloyed CuAlO$_2$/CuO. Moreover, the more diverse VBM of CuO, which was formed mainly by Cu$^{2+}$ 3d$^9$ bands, would modulate the VBM of CuAlO$_2$/CuO and make it more delocalized, leading to a high hole mobility. Indeed, the top gate TFT made by this alloyed CuAlO$_2$/CuO achieved good device performance with a high field effect mobility of 0.97 cm$^2$·V$^{-1}$·s$^{-1}$, and the schematic drawing of the TFT device with its detailed device performance is shown in Figure 4 [120].

Table 1. Summary of selected delafossites with their material properties including thickness ($d$), conductivity ($\sigma$), transmittance ($T$), and optical band gap ($E_g$). ALD: atomic layer deposition, CVD: chemical vapor deposition; PLD: pulsed laser deposition; RFMS: radio-frequency magnetron sputtering.

<table>
<thead>
<tr>
<th>Delafossites</th>
<th>Fabrication</th>
<th>$d$ (nm)</th>
<th>$\sigma$ (S·cm$^{-1}$)</th>
<th>$T$ (%)</th>
<th>$E_g$ (eV)</th>
<th>Ref.</th>
</tr>
</thead>
<tbody>
<tr>
<td>CuAlO$_2$</td>
<td>PLD</td>
<td>230</td>
<td>0.3</td>
<td>70</td>
<td>3.50</td>
<td>[111]</td>
</tr>
<tr>
<td>CuAlO$_2$</td>
<td>Hydrothermal</td>
<td>420</td>
<td>2.4</td>
<td>55</td>
<td>3.75</td>
<td>[94]</td>
</tr>
<tr>
<td>CuAlO$_2$</td>
<td>RFMS</td>
<td>110</td>
<td>$2.7 \times 10^{-2}$</td>
<td>–</td>
<td>3.79</td>
<td>–</td>
</tr>
<tr>
<td>CuScO$_2$</td>
<td>RFMS</td>
<td>120</td>
<td>2.17</td>
<td>70</td>
<td>3.00</td>
<td>[93]</td>
</tr>
<tr>
<td>CuCrO$_2$:Mg</td>
<td>RFMS</td>
<td>155</td>
<td>1</td>
<td>80</td>
<td>3.08</td>
<td>[121]</td>
</tr>
<tr>
<td>CuCrO$_2$:Mg</td>
<td>ALD</td>
<td>205</td>
<td>0.47</td>
<td>55</td>
<td>3.05</td>
<td>[122]</td>
</tr>
<tr>
<td>CuCrO$_2$:N</td>
<td>Sol-gel</td>
<td>250</td>
<td>1</td>
<td>80</td>
<td>5.15</td>
<td>–</td>
</tr>
<tr>
<td>CuCrO$_2$:Zn</td>
<td>RFMS</td>
<td>290</td>
<td>17</td>
<td>55</td>
<td>3.19</td>
<td>[123]</td>
</tr>
<tr>
<td>CuCrO$_2$</td>
<td>CVD</td>
<td>150</td>
<td>278</td>
<td>69</td>
<td>3.52</td>
<td>[124]</td>
</tr>
<tr>
<td>CuCrO$_2$</td>
<td>CVD</td>
<td>140</td>
<td>17</td>
<td>50</td>
<td>3.20</td>
<td>[125]</td>
</tr>
<tr>
<td>Cu$<em>{0.66}$Cr$</em>{1.33}$O$_2$</td>
<td>CVD</td>
<td>200</td>
<td>102</td>
<td>35</td>
<td>3.22</td>
<td>[126]</td>
</tr>
<tr>
<td>CuCrO$_2$</td>
<td>Spray coating</td>
<td>90</td>
<td>12</td>
<td>55</td>
<td>–</td>
<td>[127]</td>
</tr>
<tr>
<td>CuBO$_2$</td>
<td>PLD</td>
<td>200</td>
<td>1.65</td>
<td>85</td>
<td>4.50</td>
<td>[47]</td>
</tr>
<tr>
<td>CuGaO$_2$</td>
<td>PLD</td>
<td>500</td>
<td>$6.3 \times 10^{-2}$</td>
<td>80</td>
<td>3.60</td>
<td>[32]</td>
</tr>
<tr>
<td>CuInO$_2$:Ca</td>
<td>PLD</td>
<td>170</td>
<td>$2.8 \times 10^{-3}$</td>
<td>70</td>
<td>3.90</td>
<td>[35]</td>
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<tr>
<td>SrCu$_2$O$_3$:K</td>
<td>PLD</td>
<td>120</td>
<td>$4.8 \times 10^{-2}$</td>
<td>70</td>
<td>3.30</td>
<td>[50]</td>
</tr>
<tr>
<td>SrCu$_2$O$_2$</td>
<td>PLD</td>
<td>220</td>
<td>$4.5 \times 10^{-2}$</td>
<td>80</td>
<td>3.30</td>
<td>[128]</td>
</tr>
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</table>
Until 2018, the CuCrO$_2$ doped with Mg that was prepared by Nagarajan et al. in 2001 held the p-type conductivity record for delafossites of $220$ S·cm$^{-1}$, which also supported the effectiveness of such an approach to improve p-type conductivity [136]. Possibly because this paper was published just recently, no other reports on such a high conductivity for this system with a high conductivity have been reported to be $278$ S·cm$^{-1}$ in 2018 [124]. In this study, Mg and N dopants were introduced into the CuCrO$_2$ film, which served to substitute Cr and O, respectively. With the doping concentration of $2.5\%$ Mg and a $40\%$ N$_2/(N_2+Ar)$ ratio during sputtering, the CuCrO$_2$ film had the record-high conductivity of $278$ S·cm$^{-1}$ and optical transparency of $69\%$. A theoretical study using first-principle calculation on Mg and N co-doping has also supported the effectiveness of such an approach to improve p-type conductivity [136]. Possibly because this paper was published just recently, no other reports on such a high conductivity for this system can be found. Besides the Mg–N doping, other co-doping strategies have also been studied, including Fe, Ca, Ni, Sr, Ba, and Zn have since been incorporated into the CuCrO$_2$, but their p-type conductivity is much lower than $220$ S·cm$^{-1}$ [122,132–135]. Besides the substitution at the trivalent M sites, the N atom has been used as a substitute for the O atom in CuCrO$_2$. It was found that the p-type conductivity increased by more than three orders to $17$ S·cm$^{-1}$ compared to the intrinsic state [123]. By combining both cation and anion substitution, a new record for p-type conductivity in delafossites has been reported to be $278$ S·cm$^{-1}$ in 2018 [124]. In this study, Mg and N dopants were introduced into the CuCrO$_2$ thin film, which served to substitute Cr and O, respectively. With the doping concentration of $2.5\%$ Mg and a $40\%$ N$_2/(N_2+Ar)$ ratio during sputtering, the CuCrO$_2$ film had the record-high conductivity of $278$ S·cm$^{-1}$ and optical transparency of $69\%$. A theoretical study using first-principle calculation on Mg and N co-doping has also supported the effectiveness of such an approach to improve p-type conductivity [136]. Possibly because this paper was published just recently, no other reports on such a high conductivity for this system can be found. Besides the Mg–N doping, other co-doping strategies have also been studied, including Mg–Fe [133], Mg–S [137], and Ag–Mg [138], but the electrical and optical properties are not comparable to the study on Mg–N doping [124].

Recently, Cu-deficient CuCrO$_2$ has been reported to possess a relatively high p-type conductivity, and their optical and electrical properties are tabulated in Table 1 [109,125–127,139]. In 2017, Popa et al. prepared highly Cu-deficient Cu$_{0.66}$Cr$_{1.33}$O$_2$ with a conductivity higher than $100$ S·cm$^{-1}$ without any intentional extrinsic doping, and this appears to be the highest conductivity value out of all the delafossites without extrinsic doping [126]. However, no other papers for a similarly high conductivity for this system have been reported since then. The origin of this high conductivity was proposed to be the high Cu deficiency, and the missing of part of a Cu plane was observed for the as-deposited Cu$_{0.66}$Cr$_{1.33}$O$_2$ film. After high-temperature annealing at 900 °C, the CuCrO$_2$ film restored its stoichiometric ratio with Cr$_2$O$_3$ precipitates. The electrical conductivity dropped significantly as...
the Cu defect was healed, which suggests that the Cu deficiency defect is metastable [126]. Besides the quest for only high-performance CuCrO$_2$, more cost-efficient polymer substrates that are compatible with low-temperature chemical solution methods have been developed recently, and all of the CuCrO$_2$ films that were fabricated depicted a Cu deficiency with a high p-type conductivity [109,127,139]. It is known that high-temperature processing for these p-type oxides makes them unsuitable for flexible applications using polymer substrates [140]. In 2018, Wang et al. investigated a low-process temperature at 180 °C to prepare CuCrO$_2$ delafossites, and p-n diode and organic photovoltaic devices have been prepared successfully [139]. Also, several solution-based CuCrO$_2$ thin films have been fabricated and investigated for their applications, including p-n junctions, thermoelectric devices, and organic solar cells [141–143]. Recently, Nie developed a solution-based CuCrO$_2$ thin-film transistor (TFT) device [109]. A high on/off ratio of around 10$^6$ and good field effect mobility of 0.59 cm$^2$·V$^{-1}$·s$^{-1}$ was achieved.

The good performance of CuCrO$_2$ encouraged research groups to study the effect of trivalent M in CuMO$_2$ delafossites in detail. It has been explained before that the presence of Cu–O–Cu linkage in Cu$_2$O gives a high hole mobility in Cu$_2$O because of the hybridization of Cu and O states, but the trivalent M is involved in the Cu–O–M–O–Cu linkage in delafossites. This would lead to a lower mobility in delafossites. On the other hand, the higher conductivity of CuCrO$_2$ might be caused by the hybridization of Cr 3d states in the linkage [42]. It has also been theoretically shown that Cr 3d states would hybridize with O 2p states to form more dispersed VBM, leading to lower hole effective mass [131]. However, different conducting mechanisms of Mg-doped CuCrO$_2$ have been proposed over the years, including the p-type conduction through Cu$^{2+}$/Cu$^+$ [134] or Cr$^{4+}$/Cr$^{3+}$ [144]. Unfortunately, the exact role of trivalent M on the conductivity is still not fully understood yet. This complexity is partially caused by the difficulty to locate the exact Cr 3d state energy position [134,145]. In 2013, Yokobori et al. performed resonant photoelectron spectroscopy (PES) on CuCrO$_2$:Mg, and the Cu–Cr 3d–3p resonant PES spectra showed that VBM was primarily composed of Cr 3d states [146]. This work suggested that the holes generated in the oxides would also be delocalized to Cr sites, leading to a larger hole mobility. However, this report also showed that holes would be localized onto Cu sites according to X-ray absorption spectroscopy (XAS). Nevertheless, it is generally believed that the VBM is mainly formed by Cu 3d states, and this is consistent with the X-ray photoelectron spectroscopy (XPS) studies [129]. Another theoretical study by Scanlon et al. suggested that the high p-type conductivity of CuCrO$_2$ originates from the well hybridization of Cr 3d states with O 2p states, which would improve hole conductivity [56]. Indeed, more experimental and theoretical studies should be carried out to investigate the mechanism of conductivity enhancement for CuCrO$_2$ and compare it to other delafossites. Another controversial issue for CuCrO$_2$ is whether it is a direct or indirect band-gap oxide [29,147,148]. It has been often reported to have an indirect band gap around 2.5–2.8 eV and a direct band gap around 3.0–3.3 eV [29], although it was also shown to possess only a fundamental band gap of 3.2 eV [147]. A later detailed simulation study has proven that CuCrO$_2$ indeed possesses an indirect band gap [56].

By building on the studies of trivalent M effects, CuBO$_2$ was later proposed as a potential p-type TCO [47]. This is because the B in CuBO$_2$ has the smallest ionic size in the delafossite family, which will significantly increase the optical band gap according to the theoretical studies [77,149]. Snure et al. prepared CuBO$_2$ film by using PLD for the first time, and a decent p-type conductivity of 1.65 S·cm$^{-1}$ with a high optical transparency higher than 85% at the 550-nm wavelength was achieved [47]. However, it was noted that an indirect band gap at 2.2 eV was observed, and transmittance dropped greatly below the 550-nm wavelength. Later studies have been carried out to prepare nanocrystalline or microstructure CuBO$_2$ via chemical solution methods, although the performance in terms of the electrical conductivity and optical transmittance is not comparable to the CuCrO$_2$ films, as discussed before [150–152]. Another popular delafossite under intense research investigation is CuGaO$_2$, which was firstly prepared by Yanagi et al. in 2000 [33]. Early studies showed that CuGaO$_2$ has rather good optical transparency (higher than 80%) with decent electrical conductivity [32]. Due to its good
optical properties and ease of nanostructure synthesis, CuGaO\(_2\) has been studied for the applications of p-type dye-sensitized or perovskite solar cells [54,153–156]. For example, CuGaO\(_2\) has been used as a HTL in the perovskite solar cell CH\(_3\)NH\(_3\)PbI\(_3\)–Cl\(_x\) with a high power conversion efficiency (PCE) of 18.51\% due to the good transparency, relatively high mobility, and proper low-lying VBM [54]. The structure of both the material CuGaO\(_2\) and the whole solar cell device with its band diagram is shown in Figure 5. As can be seen from the schematic energy band diagram, holes in the organic semiconducting perovskite layers can be transported to the CuGaO\(_2\) layer effectively due to their well-matched energy levels. Another promising delafossite is CuInO\(_2\), as it had been found to be a bipolar semiconductor. By either Ca or Sn doping, CuInO\(_2\) could be made into a p-type or n-type TCO, respectively, and all of the oxide transparent p-n homojunctions could be fabricated [35–37,149]. The rather unique bipolar property could be explained by the theory of equilibrium doping and the doping limit rule [149,157–160]. The VBM and CBM positions directly influence the extent of self-compensation. A higher VBM could allow for easier p-type doping, while a lower CBM could also induce easier n-type doping. In the case of CuInO\(_2\), it has a high VBM similar to other delafossites, contributing to its p-type dopability. However, the CBM lies at a much lower energy level compared to other delafossites (1.48 eV lower than CuAlO\(_2\)) due to the low-lying In states, leading to its n-type dopability [149]. It is also interesting to note that delafossites with larger ionic sizes of trivalent metal M such as CuLaO\(_2\), CuYoO\(_2\), and CuScO\(_2\) could accommodate additional oxygen atoms [161]. Unlike other delafossites with smaller M sizes such as CuCrO\(_2\), oxygen interstitials start to contribute to the p-type conductivity in those delafossites with larger M ionic sizes [38,162].

Treating thin films such as CuScO\(_2\) at a high temperature (400–500 °C) in oxygen-rich atmosphere could incorporate a large amount of oxygen (CuScO\(_{2.5}\)) and enhance the conductivity [38].

Apart from the CuMO\(_2\) delafossites discussed so far, SrCu\(_2\)O\(_2\) is another important Cu-based one that is used as a p-type transparent semiconductor. It was proposed on the same basis as the selection rules of delafossites, and it has similar working principles for the VBM formation with delafossites or CuO\(_2\) [50]. It has a tetragonal crystal structure with O–Cu–O dumbbell bonding (as shown in Figure 6a), which is similar to delafossites or CuO\(_2\). These dumbbell bonds form the one-dimension chain in a zigzag manner, so the transparency could be improved [50]. From both the first-principle calculations and experiments, SrCu\(_2\)O\(_2\) was found to possess a direct band gap of 3.3 eV, and the VBM is formed by Cu 3d–4sp orbitals and O 2p orbitals, leading to higher hole mobility [163]. Dopant K was found to be useful for the partial substitution at the Sr site to generate holes, and the conductivity improved from 3.9 × 10\(^{-3}\) to 4.8 × 10\(^{-2}\) S·cm\(^{-1}\), while the transparency at a visible range remained largely unchanged [50]. Due to its relatively low processing or deposition temperature, which are as low as 300 °C, an all-oxide transparent p-n junction (shown in Figure 6b) was made by ZnO/SrCu\(_2\)O\(_2\) with a device transparency higher than 70% and an ideality factor of 1.62 [164].
LaCuOS with Sr could increase its conductivity to 0.26 S·cm$^\text{−1}$, and many forms of oxychalcogenides with the formula LnCuOCh (Ln = La, Y, Pr, etc., and Ch = S, Se, Te, etc.) have been investigated [168]. It was later reported that doping material in 2000 by Ueda et al., many forms of oxychalcogenides with the formula LnCuOCh (Ln = La, Y, Pr, etc., and Ch = S, Se, Te, etc.) have been investigated [168]. It was later reported that doping LaCuOS with Sr could increase its conductivity to 0.26 S·cm$^\text{−1}$ [169]. The band gap would decrease when La was replaced with other Ln elements (Ln = Pr and Nd) [170]. Similarly, the band gap would decrease when sulfide (S) was replaced by other chalcogens such as Se and Te, and the p-type conductivity would increase at the same time [171]. Among the various dopants that have been used to date, Mg dopants delivered rather good results. It has been reported that LaCuOSe doped with Mg exhibited a p-type conductivity of 910 S·cm$^\text{−1}$ without an indication of transparency [63]. Another interesting oxychalcogenide is [Cu$_2$S$_2$][Sr$_2$Sc$_2$O$_3$], where [Sr$_2$Sc$_2$O$_3$] replaced the [La$_2$O$_2$] group. This undoped oxychalcogenide with a wide band gap of 3.14eV has a p-type conductivity of 2.8 S·cm$^\text{−1}$, which is even higher than the undoped CuBO$_2$ [47] that has a high intrinsic p-type conductivity in the delafossite family [172]. The source of this high undoped conductivity is its extremely high hole mobility of 150 cm$^2$·V$^\text{−1}$·s$^\text{−1}$, which is higher than any other p-type TCOs, and even higher than the highest mobility of n-type TCOs [173]. Strangely, no follow-up experimental works have been reported on this material since that work.

LnCuOCh belongs to the tetragonal system with the space group P4/nmm, and it has a layered structure with alternating [Ln$_2$O$_2$]$^{2+}$ and [Cu$_2$S$_2$]$^{2−}$ layers along the c-axis, as shown in Figure 7a. In each layer, the structure of [Ln$_2$O$_2$]$^{2+}$ has a PbO type, while that of the [Cu$_2$S$_2$]$^{2−}$ layer has an anti-PbO type [172,174]. It has also been reported that the [Ln$_2$O$_2$]$^{2+}$ layer is much more resistive to hole carriers than the [Cu$_2$S$_2$]$^{2−}$ layer, and the [Cu$_2$S$_2$]$^{2−}$ layer is indeed the hole transporting path [62]. Moreover, the two-dimensional characteristics demonstrated by the layered LnCuOCh could suggest its similarity to the artificial multiple quantum wells (MQWs). From the energy-band calculations,
it should be regarded as a natural MQW due to its hole confinement effect between the insulating \([\text{Ln}_2\text{O}_2]^2^+\) layers, which leads to many novel electronics applications [62]. This two-dimensional quantum confinement effect leading to the relatively large exciton binding energy of around 50 meV for \(\text{LnCuOCh}\), resulting in good photoluminescence (PL) performance at room temperature, which also indicates its direct band-gap characteristic [170,175].

![Figure 7. Crystal structure of (a) LnCuOCh (Ln = La, Y, Pr, etc., and Ch = S, Se, Te, etc.) and (b) \([\text{Cu}_2\text{S}_2][\text{Sr}_3\text{Sc}_2\text{O}_5]\).](image)

One of the advantages of oxychalcogenides compared to other oxides is the tunability of their physical properties [14]. By changing the chalcogen elements from S through Se to Te, the conductivity, band gap, and other physical properties can be tuned. Usually, oxides are more robust compared to chalcogenides, resulting in a limited ability to be tuned. Moreover, as the quaternary layered structure, oxychalcogenides have more degrees of freedom for exploring more possibilities. In the series of \(\text{LaCuOCh}\), the band gaps decrease from LaCuOS of 3.14 eV via LaCuOSe of 2.8 eV to LaCuOTe of 2.4 eV [176]. This is caused by the energy-level differences among the Ch p orbitals, as the VBM is formed by the hybridization between the Cu 3\(d\) and Ch p orbitals (as shown in Figure 8) [177]. Therefore, LaCuOTe has the highest degree of hybridization for its VBM, leading to the highest hole mobility among all LaCuOCh. However, it should be noted that LaCuOTe has an indirect band gap and no room temperature PL signal, and both LaCuOS and LaCuOSe have direct band gaps with intense PL signals [171]. On the other hand, for LnCuOS series, the band gaps decrease from LaCuOS of 3.14 eV via PrCuOS of 3.03 eV to NdCuOS of 2.98 eV [174]. Unlike the case for Ch substitution, as discussed before, the band gap does not correlate with the energy levels of Ln orbitals in the \([\text{Ln}_2\text{O}_2]^2^+\) layer directly [170]. Instead, the substitution of Ln from La via Pr to Nd decreases the a-axis parameter, and this would reduce the Cu–Cu distance. The reduction in the distance would lead to higher Cu 4\(s\) interaction, resulting in the Cu 4\(s\) related band broadening, and thus a lower band gap that is similar to the case of YCuOSe (shown in Figure 8) [178].
In 2000, Ueda et al. firstly introduced LaCuOS as a potential p-type oxychalcogenide in the form of polycrystalline thin film [168]. The intrinsic LaCuOS after post-annealing is a partially transparent semiconducting film with a conductivity of $1.2 \times 10^{-2}$ S·cm$^{-1}$ and transmittance higher than 70%. After 5% Sr doping, the conductivity was improved more than one order to $2.6 \times 10^{-1}$ S·cm$^{-1}$. After optimizing the Sr doping concentration to 3%, the conductivity was further increased to 20 S·cm$^{-1}$. Similarly, the incorporation of a bivalent Sr atom was also found to be effective for polycrystalline LaCuOSe and other LnCuOCh materials for conductivity enhancement [174,180]. However, Sr doping was shown to be ineffective for epitaxial LaCuOCh film, and Mg was found to be able to improve the conductivity in this case [181]. As mentioned before, the Mg-doped epitaxial film LaCuOSe by reactive solid-phase epitaxy (R-SPE) is still holding the p-type conductivity record of 910 S·cm$^{-1}$ [181].

Another interesting and surprising feature of this high conductivity film is that the mobility after doping only dropped a little, and this is because the hole carriers are transferred to the [Cu$_2$Se$_2$] layer, so the holes are not scattered by the charged impurities [184]. However, it suffers from poor transparency due to the lower band gap of 2.8 eV and subgap optical absorption ranging from 2.0 to 2.8 eV [13].

In the infrared region occurs [182]. From the Drude model, the effective mass of the holes could be calculated from FCA [183]. Moreover, such a high hole concentration is only present in such thin films with thicknesses of 40 nm, and is absent in thicker films of 150 nm, and hole concentration is much higher than the Mg doping concentration [63,175]. As the Cu concentration varies according to depth in thinner films (40-nm thickness), this suggested that the origin of hole generation is related to Cu vacancies [63]. Another interesting and surprising feature of this high conductivity film is that the mobility after doping only dropped a little, and this is because the hole carriers are transferred to the [Cu$_2$Se$_2$] layer, so the holes are not scattered by the charged impurities [184]. However, it suffers from poor transparency due to the lower band gap of 2.8 eV and subgap optical absorption ranging from 2.0 to 2.8 eV [13]. On the other hand, Mg-doped LaCuOSe, which is a p-type degenerate semiconductor, does not experience a Moss–Burstein (MB) shift, which is a blue shift of the optical absorption [185]. Instead, subgap absorption is observed, and its origin is not yet well understood [15]. This has been suggested by the observation that the acceptor defects...
in LaCuOSe keep the Fermi level above the VBM, leading to the absence of an MB shift effect [173]. Moreover, from the theoretical calculation and perspective of cation radius, Sr should be the optimal dopant, followed by Ca for LaCuOCh, instead of Mg [173]. While the explanation for this phenomenon is not clear yet, it could be related to the origin of the conduction mechanism in LnCuOCh. It has been shown that the source of p-type conductivity in LnCuOCh is Cu deficiency, where Cu vacancies are the acceptor defects [186]. The presence of Mg does not directly contribute a hole by substituting Ln sites; instead, it serves to enhance the Cu vacancies, leading to higher hole concentrations [13].

The electrical and optical properties of selected oxychalcogenides are tabulated in Table 2. Besides the improvement of the properties for LnCuOCh materials, several devices were also fabricated to demonstrate their good optoelectronic performances [187,188]. Hiramatsu et al. prepared a LED in the blue–ultraviolet region by using LaCuOSe as the p-type material and InGaZnO8 as the n-type material [187]. This p-n heterojunction has demonstrated a strong and sharp electroluminescence at the 430-nm wavelength at room temperature. Later, Yanagi et al. used LaCuOSe doped with Mg as the hole injection layer/electrode for OLEDs [188]. The LaCuOSe:Mg that was used in that work offered advantages over the widely used ITO, including a lower hole injection barrier, higher current drivability, and lower threshold voltage.

<table>
<thead>
<tr>
<th>Oxychalcogenides</th>
<th>Fabrication</th>
<th>d (nm)</th>
<th>σ (S·cm−1)</th>
<th>T (%)</th>
<th>Eg (eV)</th>
<th>Ref.</th>
</tr>
</thead>
<tbody>
<tr>
<td>LaCuOSe</td>
<td>RFMS</td>
<td>200</td>
<td>1.2 × 10−2</td>
<td>70</td>
<td>3.1</td>
<td>[168]</td>
</tr>
<tr>
<td>LaCuOSe:Sr</td>
<td>RFMS</td>
<td>150</td>
<td>20</td>
<td>60</td>
<td>3.1</td>
<td>[179]</td>
</tr>
<tr>
<td>PrCuOSe:Sr</td>
<td>RFMS</td>
<td>150</td>
<td>1.8</td>
<td>–</td>
<td>3.03</td>
<td>[174]</td>
</tr>
<tr>
<td>NdCuOSe:Sr</td>
<td>RFMS</td>
<td>150</td>
<td>0.32</td>
<td>–</td>
<td>2.98</td>
<td>[174]</td>
</tr>
<tr>
<td>LaCuOSe:Mg</td>
<td>PLD</td>
<td>40</td>
<td>910</td>
<td>30</td>
<td>2.8</td>
<td>[63]</td>
</tr>
<tr>
<td>LaCuOSe</td>
<td>PLD</td>
<td>150</td>
<td>24</td>
<td>–</td>
<td>2.8</td>
<td>[175]</td>
</tr>
<tr>
<td>YCuOSe (Bulk)</td>
<td>–</td>
<td>–</td>
<td>0.14</td>
<td>–</td>
<td>2.58</td>
<td>[178]</td>
</tr>
<tr>
<td>[Cu2S2][Sr3Sc2O5] (Bulk)</td>
<td>–</td>
<td>–</td>
<td>2.8</td>
<td>–</td>
<td>3.1</td>
<td>[172]</td>
</tr>
<tr>
<td>NdCuOSe:Mg</td>
<td>Dip coating</td>
<td>200</td>
<td>52.1</td>
<td>54.3</td>
<td>2.91</td>
<td>[189]</td>
</tr>
</tbody>
</table>

YCuOSe was synthesized by Ueda et al. in 2007, and its optical and electrical properties were studied, and this lead to a deeper understanding of the effects of Ln or Ch substitution [178]. However, YCuOSe has a rather small band gap of 2.58 eV, originating from the short Cu–Cu distances. While it has a much higher intrinsic conductivity than LaCuOSe, its small band gap limits its applications for transparent electronics. However, a similar compound, YCuOS, which is expected to depict a larger band gap, has not been successfully prepared yet, so more works should be devoted to achieve such a phase. Other than YCuOSe, another very promising oxychalcogenide [Cu2S2][Sr3Sc2O5] was proposed and synthesized by Liu et al. in polycrystalline bulk form via solid-state reaction in the same year [172]. It has a similar crystal structure as LnCuOCh, with the [La2O2]2+ layer being replaced with the [Sr2Sc2O5]2+ layer (shown in Figure 7b). The rather ionic perovskite [Sr3Sc2O5] layer serves to preserve the large direct band gap of 3.1 eV. As discussed above for the case of Ln substitution, ionic trivalent ions of a larger size such as La and bivalent ions such as Ba could replace Sr and Sc, respectively, to increase the optical band gap [10]. With the band gap enhancement, the possibility of S substitution by Se to further improve the p-type mobility could be realized without affecting the transparency in visible light range. More importantly, there are two cation sites for doping, Sr2+ and Sc3+, to enhance the conductivity compared to the single cation site in other oxychalcogenides. The high hole mobility in this layered oxychalcogenide originated from the large dispersion of VBM [10]. Unfortunately, no subsequent experimental work has been reported by any research group for this promising [Cu2S2][Sr3Sc2O5] layered material. This might partly be due to the difficulty of achieving such a phase via conventional methods, but it is worthwhile to re-investigate such a material and unfold its full potential.
So far, the most popular synthesis method to prepare \( \text{LnCuOCh} \) is solid-state reaction, which involves the mixing of precursor oxides and sulfides such as \( \text{Ln}_2\text{O}_3 \), \( \text{Ln} \), \( \text{Cu}_2\text{O} \), \( \text{Cu}_2\text{S} \), and \( \text{La}_2\text{S}_3 \), etc., and sintering at high temperature for a long time. While this is the most straightforward preparation method, some of the starting materials such as \( \text{Ln}_2\text{O}_3 \) and \( \text{Ln} \) are either very sensitive to air or expensive \[190\]. This led to the development of an alternative synthesis method. In 2008, Nakachi and Ueda developed a flux method to prepare single-crystal \( \text{LaCuOS} \) in a relatively large size of \( 3.0 \times 2.8 \times 0.049 \text{ mm}^3 \) with a low conductivity of \( 7.1 \times 10^{-4} \text{ S cm}^{-1} \) and transmittance around 60\% \[191\]. However, this method has the drawbacks of complexity in the experimental set-up, and long synthesis duration. Alternatively, chemical solution-based solvothermal and precipitation/reduction methods were proposed in 2010 and 2016, respectively, to prepare bulk \( \text{LaCuOS} \) \[192,193\]. Single-phase \( \text{LaCuOS} \) could be produced, and the solvothermal method could synthesize \( \text{LaCuOS} \) at a relatively low temperature of 200\°C, making it compatible with a flexible substrate such as polyethylene terephthalate (PET). Unfortunately, the important electrical properties of such a material were not characterized in those two reports. Then, in 2017, Zhang et al. proposed a novel two-step synthesis method by combining a solid-state reaction with a sulfurization method \[194\]. Relatively stable and low-cost starting materials including \( \text{Cu}_2\text{O} \) and \( \text{La}_2\text{O}_3 \) were used for the first step of the solid-state reaction to prepare \( \text{CuLaO}_2 \), and then, the oxide \( \text{CuLaO}_2 \) was sulfurized with \( \text{S} \) instead of the usually used compound \( \text{H}_2\text{S} \), which is highly toxic. Single-phase \( \text{LaCuOS} \) with a relatively high resistivity of 0.25 M\( \Omega \) was produced. Besides the bulk \( \text{LnCuOCh} \) synthesis, its thin film form was normally prepared by a vacuum-based deposition method including RFMS, and PLD of the \( \text{LnCuOCh} \) target prepared via a solid solution method \[168,175,181,195\]. Such a conventional thin-film fabrication method has the drawback of time-consuming target preparation and the necessity of the use of \( \text{H}_2\text{S} \) during film deposition for both PLD and sputtering. Later, in 2018, Zhang et al. successfully prepared a \( \text{LaCuOS} \) film via a hydrogen-free method without using \( \text{H}_2\text{S} \), and the schematic illustration of the fabrication process is shown in Figure 9 \[196\]. More importantly, the hydrogen-containing gas \( \text{H}_2\text{S} \) was normally used in the thin film deposition process prior to that work. This might impede the p-type performance of oxychalcogenides such as \( \text{H} \), which is known to be an n-type dopant, and might be accidentally incorporated in the deposited thin film. Therefore, the absence of \( \text{H}_2\text{S} \) in that work not only serves to be more environmental friendly, but also improves the p-type conductivity, and the intrinsic conductivity in that work is as high as 0.3 S cm\(^{-1}\) \[196\].

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**Figure 9.** Schematic illustration of the \( \text{LaCuOS} \) thin film deposition process via sputtering and post-sulfurization. Reproduced with permission from Ref. \[196\]. Copyright 2018 Elsevier.
Similar to the fabrication of delafossite thin films, the chemical solution method has the advantages of low cost fabrication, roll-to-roll capability, high throughput, and the possibility for a special nanostructure [108–110]. To explore the possibility of a solution-based fabrication approach, in 2018, Zhang et al. developed the first solution-based method, which is a dip-coating process with a post-sulfurization process to fabricate oxychalcogenide NdCuOS (shown in Figure 10) [189]. As no H-containing compound such as H₂S was used during sulfurization, the possibility of hydrogen doping in the thin film was eliminated. Moreover, the NdCuOS prepared via such a solution method was reported to contain a large Cu deficiency. The resulting intrinsic NdCuOS film demonstrated a high p-type conductivity of 6.4 S·cm⁻¹, and even a higher conductivity of 52.1 S·cm⁻¹ was achieved after Mg doping with an acceptable optical transparency higher than 50%. Moreover, a working p-n junction was made by using this intrinsic NdCuOS as a p-type terminal, and ZnO doped with Al as an n-type terminal. A low turn-on voltage of 1.1 V and a rather low leakage current of 9.12 μA at −3 V was obtained for this transparent diode [189].

Copper oxides have two forms: cupric oxide (CuO) and cuprous oxide (Cu₂O). CuO has a tenorite structure, and Cu₂O has a cubic crystal structure (shown in Figure 11). The optical band gap of CuO is between 1.9–2.1 eV, and that of Cu₂O is between 2.1–2.6 eV, and the low band gaps makes the film non-transparent for a range of the visible light, as the visible light energy reaches 3.1 eV [197,198]. They are both reported to be p-type oxides, but the small band gap limits their applications. Thin-film transistor (TFT) is an important application for copper oxide as an active material. Compared with CuO, Cu₂O can theoretically exhibit a hole mobility exceeding 100 cm²·V⁻¹·s⁻¹, and so it receives more attention [197]. It is recently accepted that the high p-type mobility of Cu₂O is the result of the band structure of VBM [197]. It has been shown that the p-type mobility of Cu₂O is the result of the band structure of VBM [197]. It has been shown that the p-type

![Figure 10. Schematic illustration of the solution-based (dip-coating) process with post-annealing to prepare NdCuOS film. Reproduced with permission from Ref. [189]. Copyright 2018 Elsevier.](image-url)

2.3. Copper Oxides

Copper oxides have two forms: cupric oxide (CuO) and cuprous oxide (Cu₂O). CuO has a tenorite structure, and Cu₂O has a cubic crystal structure (shown in Figure 11). The optical band gap of CuO is between 1.9–2.1 eV, and that of Cu₂O is between 2.1–2.6 eV, and the low band gaps makes the film non-transparent for a range of the visible light, as the visible light energy reaches 3.1 eV [197,198]. They are both reported to be p-type oxides, but the small band gap limits their applications. Thin-film transistor (TFT) is an important application for copper oxide as an active material. Compared with CuO, Cu₂O can theoretically exhibit a hole mobility exceeding 100 cm²·V⁻¹·s⁻¹, and so it receives more attention [197]. It is recently accepted that the high p-type mobility of Cu₂O is the result of the band structure of VBM [197]. It has been shown that the p-type mobility of Cu₂O is the result of the band structure of VBM [197]. It has been shown that the p-type
conductivity of Cu$_2$O is from the Cu vacancies [197]. At the same time, it has also been reported that the presence of oxygen interstitials could contribute to p-type conductivity [9,199]. Cu$_2$O films can be fabricated by various techniques, which are mainly vacuum-based, such as RFMS [64,200–202], ALD [203–205], and PLD [206–208]. In 2008, Li et al. reported a high Hall mobility of 256 cm$^2$·V$^{-1}$·s$^{-1}$ in their Cu$_2$O thin film deposited by RFMS at a substrate temperature of 600 °C, which is the highest so far for Cu$_2$O films [64]. Zou et al. reported a pure phase polycrystalline Cu$_2$O by PLD at 500 °C, with a Hall mobility of 107 cm$^2$·V$^{-1}$·s$^{-1}$ [209]. Jeong and Aydil reported a Cu$_2$O film with a Hall mobility over 30 cm$^2$·V$^{-1}$·s$^{-1}$ by metal–organic chemical vapor deposition (MOCVD) at 400 °C [210]. Kwon et al. fabricated Cu$_2$O films by atomic layer deposition with a Hall mobility of 0.78 cm$^2$·V$^{-1}$·s$^{-1}$ at low-temperature by a solution-processed method with a mobility of 4.3 cm$^2$·V$^{-1}$·s$^{-1}$ and an on/off ratio of 10$^7$, which is the best until now for the copper oxide-based TFTs [209]. Yao et al. reported p-type Cu$_2$O TFTs by sputtering, which showed a field-effect mobility of 2.4 cm$^2$·V$^{-1}$·s$^{-1}$ [216]. In 2013, Kim et al. presented the first solution processed p-type Cu$_2$O TFTs with a field-effect mobility of 0.16 cm$^2$·V$^{-1}$·s$^{-1}$ [213]. Anthopoulos et al. reported Cu$_2$O films by solution-based spray pyrolysis and incorporated them into p-type TFTs with a mobility of 0.01 cm$^2$·V$^{-1}$·s$^{-1}$ and an on/off current ratio of 10$^5$ [217]. In 2016, Shan et al. fabricated Cu-based oxide TFTs at low-temperature by a solution-processed method with a mobility of 0.78 cm$^2$·V$^{-1}$·s$^{-1}$ and an on/off current ratio of 10$^5$ [218]. In 2017, Liu et al. reported low-temperature solution-processed p-type Cu$_2$O thin film-based TFTs with Al$_2$O$_3$ dielectrics, which presented a hole mobility of 2.7 cm$^2$·V$^{-1}$·s$^{-1}$ and an on/off ratio of 10$^5$ [219]. While the device performance is encouraging, it should be noted that the rather low band gap or optical transparency would make Cu$_2$O have limited applications in transparent devices.

3. Summary and Perspectives

In this review, we have illustrated and discussed the material performance of Cu-based oxides (delafossites and copper oxides) and oxychalcogenides (LnCuOCh) for p-type TCO applications. All three types of materials make use of the special feature of Cu$^+$ 3$d$ orbitals, which are close to O 2$p$ orbitals and could hybridize with each other to form a more spatially dispersed VBM, leading to higher hole mobility. Moreover, oxychalcogenides LnCuOS VBM is actually formed by the hybridization of Cu 3$d$ orbitals and S 3$p$ orbital states, and this allows for even higher mobility. Over the years,
many strategies had been developed to improve the hole mobility of the materials. For example, non-isovalent CuO has been introduced into polycrystalline CuAlO$_2$ film to achieve the hybridization of Cu–O dimers in the CuAlO$_2$ lattice, and resulting in a higher Hall mobility [120]. At the same time, many approaches have been investigated to enhance the p-type conductivity by increasing the hole concentration. Different strategies are suitable for different applications, as certain applications such as TFT would prefer TCO with high mobility, while other applications such as HTL in photovoltaics need TCO with high hole concentrations and conductivity.

While many promising results have been generated recently in terms of the p-type conductivity of Cu-based oxides and oxychalcogenides, their mobility and conductivity are still far poorer than their n-type counterparts. In order to further improve their performance, several important issues could be tackled. Firstly, more high-throughput computational studies could be carried out to find potential p-type TCOs with intrinsically higher hole mobility and the ease of p-type doping. Secondly, both cation and anion doping should be investigated in detail, as only very limited studies have been reported for anion doping for Cu-based oxides and oxychalcogenides. Thirdly, more research efforts should be involved in the study of some reported Cu-based oxides and oxychalcogenides with high potential. For instance, [Cu$_2$S$_2$][Sr$_3$Sc$_2$O$_5$] has very high undoped p-type conductivity with two cation sites for doping to further improve both transparency and conductivity, but only one experimental work has been reported for this material. Last but not least, the investigation of bipolar semiconductors should be given more research attention, so that the transparent electronics based on homojunction could be realized. With these four non-exclusive avenues for future p-type TCOs research, we believe that more promising results should be expected.

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